## Notice of References Cited Application/Control No. 10/506,467 Examiner Yong Sim Applicant(s)/Patent Under Reexamination LIU ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,646,377 A	07-1997	Oda, Yasuo	178/18.07
*	В	US-6,476,799 B1	11-2002	Lee et al.	345/174
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Η	US-			
	ı	US-			
	7	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	α					
	R					
·	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.